

# Abstracts

## Comparison of air coplanar microprobes for on-wafer measurements at W-band

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A. Pham, J. Laskar, S. Basu and J. Pence. "Comparison of air coplanar microprobes for on-wafer measurements at W-band." 1997 MTT-S International Microwave Symposium Digest 3. (1997 Vol. III [MWSYM]): 1659-1662.

We apply the on-wafer thru-reflect-line (TRL) and thru-reflect-match calibrations and measurements to evaluate and compare the performance of waveguide and coax fed microprobes at W-band. The results compare the repeatability, isolation, and performance of these probes.

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